Notice of References Cited Application/Control No. 10/565,067 Applicant(s)/Patent Under Reexamination OGURA ET AL. Examiner TUYET VO Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,597,130	07-2003	Lee et al.	315/294
*	В	US-6,891,338	05-2005	Kubo, Yoshio	315/291
*	С	US-2002/0135572	09-2002	Weindorf, Paul F. L.	345/204
*	D	US-2004/0075402	04-2004	Morishita, Isaya	315/308
*	E	US-2004/0145584	07-2004	Lee et al.	345/212
*	F	US-2005/0212790	09-2005	Lin et al.	345/204
*	G	US-2005/0237010	10-2005	Ying et al.	315/312
*	Н	US-2006/0192927	08-2006	Ikeuchi et al.	353/119
*	ı	US-2007/0114953	05-2007	KIM et al.	315/307
*	J	US-2008/0012502	01-2008	Lys, lhor A.	315/247
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	8	` .
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.